

Time-efficient logical operations on quantum LDPC codes

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We propose schemes capable of measuring an arbitrary set of commutative logical Pauli operators in time independent of the number of operators. The only condition is commutativity, a fundamental requirement for simultaneous measurements in quantum mechanics. Quantum low-density parity check (LDPC) codes show great promise for realising fault-tolerant quantum computing. They are particularly significant for early fault-tolerant technologies as they can encode many logical qubits using relatively few physical qubits. By achieving simultaneous measurements of logical operators, our approaches enable fully parallelised quantum computing, thus minimising computation time. Our schemes are applicable to any quantum LDPC codes and maintain the low density of parity checks while measuring multiple logical operators simultaneously. These results enhance the feasibility of applying early fault-tolerant technologies to practical problems.

I. INTRODUCTION

Quantum error correction is crucial for many quantum computing applications, such as breaking cryptographic systems and simulating quantum many-body physics [1, 2]. The primary challenge of quantum error correction lies in the substantial number of physical qubits required for encoding [3]. Quantum low-density parity check (LDPC) codes offer an advantage in this regard due to their low overhead [4, 5]. Recent progresses demonstrate that the long-range connectivity needed to implement low-overhead quantum LDPC codes is feasible in neutral atom and ion trap systems [6–8]. Furthermore, numerical results indicate that quantum LDPC codes can tolerate relatively high physical error rates [9–11]. These advancements underscore the potential of quantum LDPC codes as a pivotal pathway to achieving fault-tolerant quantum computing [12].

A promising method for implementing logical operations on quantum LDPC codes is lattice surgery [13–15]. In this approach, an ancilla system is coupled with the memory enabling the measurement of logical qubits [10, 16]. However, multiple logical measurements involving the same physical qubits cannot be executed simultaneously to maintain the low density of parity checks. This issue hinders the parallelisation of logical operations and can potentially increase the time required for quantum computations. Since fundamental physical operations on qubits are considerably time-consuming, the complexity resulting from the lack of parallelisation is particularly important. It may ultimately limit the practical applications of quantum computing.

In this paper, we propose two schemes for simultaneous measurements on multiple logical operators. Our schemes allow for the measurement of an arbitrary set of commutative logical Pauli operators in time independent of the number of operators. For instance, the operator set could be $\{\bar{X}_1, \bar{X}_2\bar{Z}_3, \bar{Y}_2\bar{Y}_3\bar{X}_4 \cdots \bar{Z}_k, \dots\}$, where $\bar{X}_j, \bar{Y}_j, \bar{Z}_j$

are Pauli operators of the j th logical qubit. Here, commutativity is the only condition, and it is a fundamental requirement in quantum mechanics: only commutative operators have common eigenstates, allowing simultaneous measurement [17]. The simultaneous measurements, supplemented with the preparation of magic states, enable fully parallelised universal quantum computing, i.e. logical operations can be performed in parallel as long as they commute with each other.

The simultaneous measurements are achieved through two types of ancilla systems: measurement stickers and branch stickers. The function of a sticker is determined by a linear code, referred to as the glue code. One of the schemes, termed devised sticking, employs a single measurement sticker. By adjusting the glue code, we can realise the desired simultaneous measurement. In the other scheme, termed brute-force branching, we concatenate branch and measurement stickers to propagate the logical operators to different stickers for simultaneous measurement. Both schemes maintain the low density of parity checks.

II. PROBLEMS

The difficulty in simultaneously measuring an arbitrary set of logical operators arises from the overlap of logical operators, as shown in Fig. 1. In lattice surgery, the method to measure a logical operator involves coupling an ancilla system to the physical qubits within the support of this operator. To measure multiple logical operators simultaneously, we can use multiple ancilla systems, with each ancilla system measuring one logical operator by coupling it to the corresponding support. However, due to the overlap of logical operators, this approach might result in some physical qubits being coupled to multiple ancilla systems, thereby violating the LDPC condition. This problem has been noticed in Refs. [10, 16]. Another method for simultaneously measuring multiple logical operators is to couple an ancilla system to the union of the supports of all the logical operators to be measured. Due to the overlap of logical operators,

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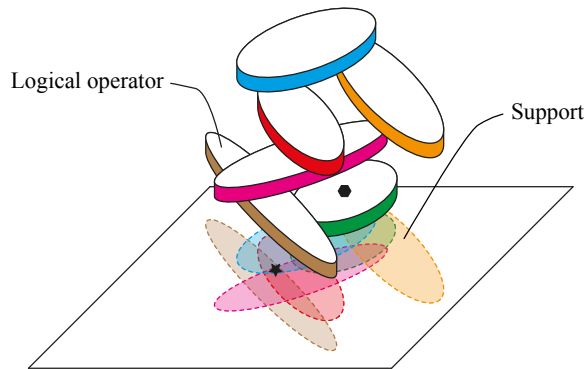


FIG. 1. Logical operators and their supports. In the region marked by the star, each physical qubit is in supports of four logical operators. The logical operator marked by the hexagon is contained in supports of other logical operators.

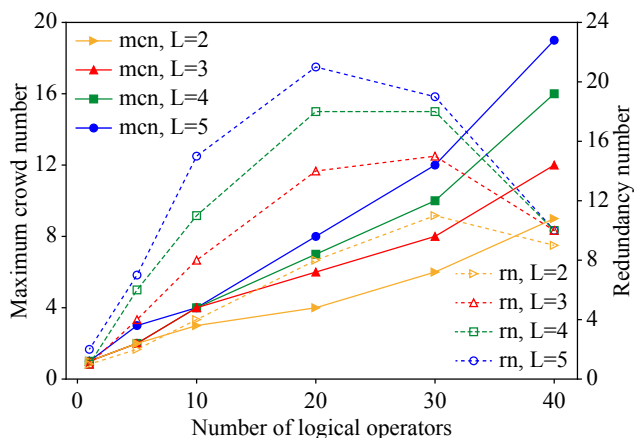


FIG. 2. Median values of the maximum crowd number (mcn) and redundancy number (rn) for a quantum low-density parity check code. For each number of logical operators q , we randomly generate the operator set Σ for one hundred times. The set Σ consists of Z logical operators acting non-trivially on up to L logical qubits. For each Σ , we evaluate the maximum crowd number among all physical qubits and the redundancy number. The redundancy number decreases when the operator number q is greater than half of the total logical qubit number $k = 50$, because the redundancy number is always not larger than $k - q$.

the union of the supports might contain logical operators that do not need to be measured. However, these redundant logical operators may also be measured by the ancilla system, leading to incorrect logical operations. In this work, we address both issues, enabling the simultaneous measurement of an arbitrary set of logical Pauli operators.

Due to their high encoding rate, quantum LDPC codes are prone to logical-operator overlap. We can use two quantities to characterise the overlap, corresponding to the two issues mentioned above, respectively. Let $\Sigma =$

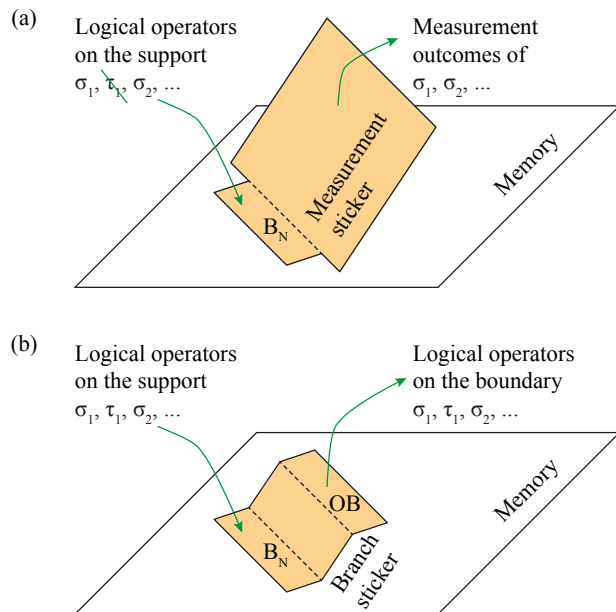


FIG. 3. (a) A measurement sticker pasted on \mathcal{B}_N on the memory. Logical operators contained in \mathcal{B}_N include $\sigma_1, \sigma_2, \dots$ and τ_1, \dots . We can choose to measure $\sigma_1, \sigma_2, \dots$ by designing an appropriate measurement sticker. (b) A branch sticker pasted on \mathcal{B}_N on the memory. Logical operators contained in \mathcal{B}_N are transferred to the open boundary (OB) of the branch sticker. By transferring the logical operator σ , we mean there exists a stabiliser operator g such that the support of $g\sigma$ is on OB.

$\{\sigma_1, \sigma_2, \dots, \sigma_q\}$ be a subset of $Z(X)$ logical operators. For a physical qubit, its crowd number is the number of operators in Σ acting non-trivially on that physical qubit. The redundancy number of Σ is the number of $Z(X)$ logical operators that are contained in the union of supports but not in Σ (we only count independent operators). See Appendix A for formal definitions. In Fig. 2, we demonstrate how these two quantities change with the size of Σ using a $[[1922, 50, 16]]$ code as an example [18, 19]. We find that the problem of logical-operator overlap becomes more severe as the size of Σ grows.

III. SCHEMES

We employ two methods to measure multiple logical operators simultaneously, devised sticking and brute-force branching. These two methods solve the two problems caused by logical-operator overlap, respectively. In devised sticking, we use only one ancilla system, called measurement sticker, and couple it with a subset \mathcal{B}_N of physical qubits on the memory. By designing an appropriate measurement sticker, we can measure any selected subset (rather than all) of logical operators contained in \mathcal{B}_N , as shown in Fig. 3(a). In brute-force branching, we use another type of ancilla system called branch sticker.

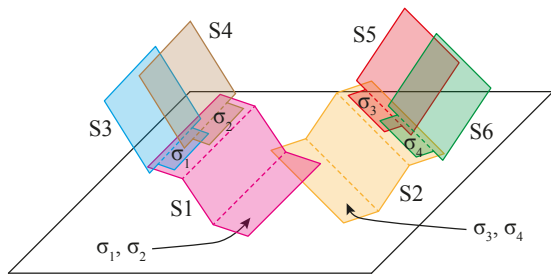


FIG. 4. Brute-force branching for measuring four logical operators.

Unlike a measurement sticker, the role of a branch sticker is to transfer logical operators from the memory to the sticker (specifically to a subset of physical qubits on the sticker, called its open boundary), as shown in Fig. 3(b). Through the concatenation of branch stickers, we can transfer the logical operators to different stickers for measurement, thereby eliminating the overlap between logical operators. Then, we can measure each logical qubit using a measurement sticker without violating the LDPC condition.

Fig. 4 illustrates brute-force branching with the measurement of four overlapping logical operators as an example. First, we paste the branch sticker $S1$ ($S2$) on the supports of σ_1 and σ_2 (σ_3 and σ_4), transferring σ_1 and σ_2 (σ_3 and σ_4) to the open boundary of $S1$ ($S2$). Then, we paste the measurement sticker $S3$ on the support of σ_1 on the branch sticker $S1$, achieving the measurement of σ_1 . Similarly, we use measurement stickers $S4$, $S5$ and $S6$ to measure σ_2 , σ_3 and σ_4 , respectively.

In general, brute-force branching works in the following way. Suppose we want to measure a set of logical operators Σ . Let q be the number of operators in Σ . First, we paste two branch stickers $S0$ and $S1$ on supports of $\{\sigma_1, \dots, \sigma_{q/2}\}$ and $\{\sigma_{q/2+1}, \dots, \sigma_q\}$, respectively. Next, on the open boundary of $S0$ ($S1$), we paste two branch stickers $S00$ and $S01$ ($S10$ and $S11$) on the supports of $\{\sigma_1, \dots, \sigma_{q/4}\}$ and $\{\sigma_{q/4+1}, \dots, \sigma_{q/2}\}$ ($\{\sigma_{q/2+1}, \dots, \sigma_{3q/4}\}$ and $\{\sigma_{3q/4+1}, \dots, \sigma_q\}$), respectively. In this way, we concatenate branch stickers for $\log_2 q - 1$ levels. In the final level, each branch sticker is pasted on the supports of two logical operators. Finally, we paste two measurement stickers on each final-level branch sticker to measure the logical operators. In this method, the memory is coupled only to two stickers, and each branch sticker is coupled only to two next-level stickers, thereby ensuring the LDPC condition.

Using either of the two methods, devised sticking and brute-force branching, we can simultaneously measure an arbitrary set of X or Z logical operators. By introducing ancilla logical qubits, we can further achieve simultaneous measurement of an arbitrary set of general logical Pauli operators subject to the commutativity condition. To measure a general Pauli operator, we decompose it into a product of an X operator and a Z operator.

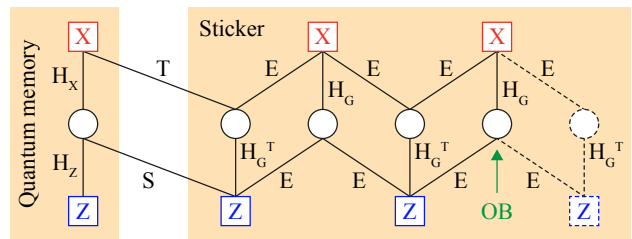


FIG. 5. Tanner graph of a measurement sticker pasted on the quantum memory. Each circle represents a set of qubits, each square represents a set of X or Z parity checks, and each edge represents a check matrix. H_X and H_Z are check matrices of the memory. H_G is the check matrix of the glue code. S and T are pasting matrices. E is the identity matrix. If removing the dashed circle, square and edges, we obtain a branch sticker, and the arrow indicates the open boundary (OB). The length of a sticker d_R is the number of Z squares. See Appendix D for the matrix representation of the code.

We apply joint measurements on these two sub-operators and an ancilla logical qubit through devised sticking or brute-force branching, reading out the general Pauli operator without affecting sub-operators. In what follows, we focus on the simultaneous measurement of Z logical operators. The simultaneous measurement of X logical operators is similar. The protocol for the simultaneous measurement of general logical Pauli operators is given in Appendix H.

IV. STICKERS AND GLUE CODES

A sticker is a hypergraph product code [19, 20], as shown in Fig. 5. For a measurement sticker, one of the two linear codes that generate the hypergraph product code is called the glue code; the other linear code is a repetition code. Branch stickers are similar. By deleting a bit in the repetition code, we obtain the hypergraph product code for a branch sticker. Stickers are coupled to the memory through two matrices, S and T , called pasting matrices. Let H_G and H_X be the check matrices for the glue code and X operators of the memory, respectively. We say that the glue code is compatible with the memory if and only if there exist matrices S and T that satisfy the equation $H_X S^T = T H_G$.

The glue code determines which logical operators the sticker acts on. Let Σ be the set of Z logical operators to be acted on. For a measurement sticker, we need to choose an appropriate glue code such that only operators in Σ are measured, and no other logical operators are measured. We refer to such a glue code as finely devised for Σ . For a branch sticker, the requirement for the glue code is weaker. A branch sticker does not measure any logical operators (and thus does not destroy any logical information), so we do not need to exclude logical operators outside Σ . That is, we need a glue code that can transfer the operators in Σ , but it may also transfer

other logical operators simultaneously. We refer to such a glue code as coarsely designed for Σ . We provide rigorous definitions of the two types of glue codes in Appendix B.

Theorem 1. *For an arbitrary quantum LDPC code and an arbitrary set of Z logical operators Σ , there exist coarsely and finely devised glue codes for Σ . The check matrix of the glue code H_G and the corresponding pasting matrices S and T have a weight upper bounded by a factor independent of code parameters, i.e. satisfy the LDPC condition. Let $r_G \times n_G$ be the dimension of H_G . For the coarsely devised glue code, $n_G, r_G = \Omega(n_N)$, where n_N denotes the size of the union of supports for Σ . For the finely devised glue code, $n_G, r_G = \Omega(n_N + (k_N - q)q)$, where q is the number of independent operators in Σ , and k_N is the number of independent Z logical operators contained in the union of supports.*

Notice that $k_N - q$ is the redundancy number of Σ . In Appendix G, we provide a more formal statement of the above theorem and its proof. The proof contains algorithms for generating coarsely and finely devised glue codes.

V. DEFORMED CODES

By pasting one or more stickers to the memory, we obtain a deformed code. For a single sticker, the deformed code is shown in Fig. 5. For multiple stickers, we can construct the deformed code as follows: first, paste one sticker to the memory and treat the resulting deformed code as the new memory; then, paste the second sticker to the new memory; and so on. By pasting all the stickers to the memory, we generate the final deformed code. Based on the generated deformed code, we can perform logical measurements using lattice surgery.

The steps for lattice surgery are as follows: 1) Initialise the physical qubits on all stickers to the state $|+\rangle$; 2) Perform parity-check measurements according to the deformed code and repeat this for d_T times; 3) Measure physical qubits on all stickers in the X basis. The above steps can be used to measure Z logical operators simultaneously. For X logical operators, we need to construct the corresponding deformed code and then perform lattice surgery using similar steps. For general logical Pauli operators, we need ancilla logical qubits. For each operator to be measured, we need one (or three in some cases) ancilla logical qubit(s). By performing one round (or three rounds in some cases) of the simultaneous measurement on X or Z logical operators that involve ancilla qubits, we can achieve the measurement of an arbitrary set of logical Pauli operators. See Appendix H for the protocols of measurements on general logical Pauli operators and discussions on universal quantum computing.

According to Theorem 4, the deformed code is always a quantum LDPC code. Besides the LDPC condition, the deformed code also needs to have a sufficiently large

code distance. The properties of the deformed code are given by the following theorem.

Theorem 2. *The deformed code is suitable for lattice surgery and can achieve the corresponding operations on Z logical operators. Let d be the code distance of the memory, and let d_R be the code distance of the repetition code generating the sticker. For a measurement sticker, the code distance of the deformed code has a lower bound of $\min\{d/|S|, d_R\}$. For a branch sticker, the code distance of the deformed code has a lower bound of $d/|S|$. Here, $|S|$ is the norm of the matrix S induced by the Hamming weight.*

Notice that we can always choose S such that $|S| = 1$. In Appendix F, we provide a more formal statement of the above theorem and its proof. Additionally, in Appendix I, we present a detailed comparison of stickers used in our methods with ancilla systems proposed in Ref. [16].

VI. COSTS

The time required for simultaneous measurements depends on the parameter d_T in lattice surgery. To suppress measurement errors, parity-check measurements need to be repeated sufficiently many times, meaning d_T must be sufficiently large. Usually, the rate of relevant logical errors decreases exponentially with d_T . Therefore, we can take $d_T = \Omega(\log \frac{1}{\epsilon})$ to achieve a permissible logical error rate ϵ . Consequently, the time cost is $\Omega(\log \frac{1}{\epsilon})$. Regarding the number of operators to be measured, the time cost is independent of the operator number.

The qubit overhead depends on the measurement method. In devised sticking, a finely devised glue code is required to construct the measurement sticker. For the measurement sticker, a sufficiently large d_R of the repetition code is required, i.e. $d_R = \Omega(\log \frac{1}{\epsilon})$. Thus, a finely devised measurement sticker requires $\Omega(Ldq^2 \log \frac{1}{\epsilon})$ physical qubits. Here, we have taken that for each logical qubit, the weight of its Z operator is $\Omega(d)$; then $n_N, k_N = \Omega(Ldq)$, where L is the maximum logical weight of operators to be measured (the logical weight is the number of logical qubits that a logical operator acts non-trivially on). For branch stickers in brute-force branching, only a coarsely devised glue code is needed, and we can take $d_R = 2$. Therefore, we need $\Omega(Ldq \log q + Ldq \log \frac{1}{\epsilon})$ physical qubits to construct stickers in brute-force branching. In the above analysis, brute-force branching is favourable over devised sticking in terms of the qubit cost scaling with q .

In Fig. 6, we use a $[[1922,50,16]]$ code and a $[[578,162,4]]$ code as examples to illustrate the qubit costs in devised sticking and brute-force branching [18, 19]. We find that the actual qubit cost in devised sticking is smaller than brute-force branching.

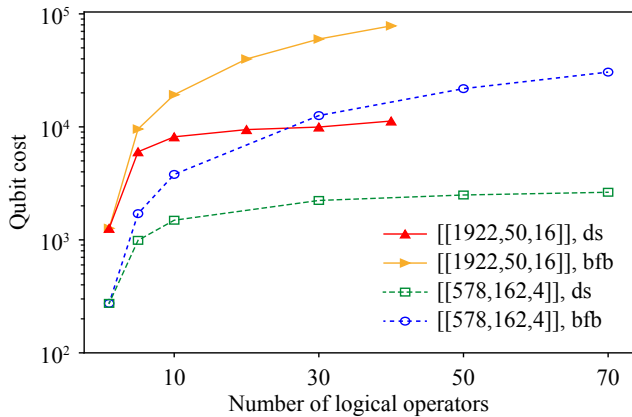


FIG. 6. Median values of the qubit number required in simultaneous measurements. For each number of logical operators q , we randomly generate the operator set Σ for one hundred times. The set Σ consists of Z logical operators acting non-trivially on up to $L = 5$ logical qubits. For each Σ , we evaluate the qubit costs in devised sticking (ds) and brute-force branching (bfb).

VII. CONCLUSIONS

In this work, we propose two schemes of constructing deformed codes for lattice surgery, enabling the simultaneous measurements of arbitrary logical Pauli operators. We rigorously analyse the code distance and the weight of check matrices. We also estimate the number of qubits required for the simultaneous measurements. The results demonstrate that fully parallelised fault-tolerant quantum computing can be achieved on arbitrary quantum LDPC codes.

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Appendix A: Preliminaries

Subsystem codes. We denote a CSS subsystem code [21] with a six-tuple $(H_X, H_Z, J_X, J_Z, F_X, F_Z)$, where H_X, J_X and F_X (H_Z, J_Z and F_Z) are the check matrix, logical-operator generator matrix and gauge-operator generator matrix of X (Z) operators, respectively. Suppose the code parameters are $[n, k, d]$. Then, $H_X \in \mathbb{F}_2^{r_X \times n}$, $H_Z \in \mathbb{F}_2^{r_Z \times n}$, $J_X, J_Z \in \mathbb{F}_2^{k \times n}$ and $F_X, F_Z \in \mathbb{F}_2^{k_g \times n}$, where $k_g = n - \text{rank}H_X - \text{rank}H_Z - k$ is the number of gauge qubits. These matrices satisfy

$$\ker H_X = \text{rs}H_Z \oplus \text{rs}J_Z \oplus \text{rs}F_Z, \quad (\text{A1})$$

$$\ker H_Z = \text{rs}H_X \oplus \text{rs}J_X \oplus \text{rs}F_X, \quad (\text{A2})$$

$$J_X J_Z^T = E_k, \quad (\text{A3})$$

$$F_X F_Z^T = E_{k_g}, \quad (\text{A4})$$

where $\text{rs}A$ is the row space of the matrix A , and E_k is the k -dimensional identity matrix. The code distance is

$$d = \min\{d(H_X, J_X), d(H_Z, J_Z)\}, \quad (\text{A5})$$

where

$$d(H, J) \equiv \min_{e \in \ker H \mid J e^T \neq 0} |e|, \quad (\text{A6})$$

where $|\bullet|$ denotes the Hamming weight.

Let X_j (Z_j) be the X (Z) operator of the j th qubit. Let $X(v)$ and $Z(v)$ be the X and Z operators of the vector $v \in \mathbb{F}_2^n$, respectively, i.e.

$$X(v) \equiv X_1^{v_1} X_2^{v_2} \cdots X_n^{v_n}, \quad (\text{A7})$$

$$Z(v) \equiv Z_1^{v_1} Z_2^{v_2} \cdots Z_n^{v_n}. \quad (\text{A8})$$

The stabiliser of the code is

$$\mathcal{S} = \left\langle X(H_{X;i,\bullet}), Z(H_{Z;j,\bullet}) \mid i = 1, 2, \dots, r_X \text{ and } j = 1, 2, \dots, r_Z \right\rangle. \quad (\text{A9})$$

Here, $A_{i,\bullet}$ ($A_{\bullet,j}$) denotes the i th row (j th column) of the matrix A . The X and Z operators of the j th logical qubit are $X(J_{X;j,\bullet})$ and $Z(J_{Z;j,\bullet})$, respectively. Then,

$$\mathcal{X} = \langle X(J_{X;j,\bullet}) \mid j = 1, 2, \dots, k \rangle \quad (\text{A10})$$

and

$$\mathcal{Z} = \langle Z(J_{Z;j,\bullet}) \mid j = 1, 2, \dots, k \rangle \quad (\text{A11})$$

are the groups of X and Z logical operators, respectively.

Hypergraph product codes. Let $H_1 \in \mathbb{F}_2^{r_1 \times n_1}$ and $H_2 \in \mathbb{F}_2^{r_2 \times n_2}$ be check matrices of two binary linear codes, respectively. A hypergraph product code generated by H_1 and H_2 is a quantum code with check matrices

$$H_X = (H_1 \otimes E_{n_2} \quad E_{r_1} \otimes H_2^T), \quad (\text{A12})$$

$$H_Z = (E_{n_1} \otimes H_2 \quad H_1^T \otimes E_{r_2}). \quad (\text{A13})$$

Repetition code. A repetition code of length n is a binary linear code with the check matrix

$$\lambda_n = (E_{n-1} \quad 0_{n-1,1}) + (0_{n-1,1} \quad E_{n-1}), \quad (\text{A14})$$

where $0_{a,b}$ is an $a \times b$ zero matrix. Furthermore, $\lambda_{n,\bullet,1:n-1}$ is the matrix generated by deleting the n th column from λ_n .

For examples, the check matrix of the length-5 repetition code is

$$\lambda_5 = \begin{pmatrix} 1 & 1 & 0 & 0 & 0 \\ 0 & 1 & 1 & 0 & 0 \\ 0 & 0 & 1 & 1 & 0 \\ 0 & 0 & 0 & 1 & 1 \end{pmatrix}, \quad (\text{A15})$$

and

$$\lambda_{5,\bullet,1:4} = \begin{pmatrix} 1 & 1 & 0 & 0 \\ 0 & 1 & 1 & 0 \\ 0 & 0 & 1 & 1 \\ 0 & 0 & 0 & 1 \end{pmatrix}. \quad (\text{A16})$$

Tanner graphs. We can represent check matrices of a quantum code with a Tanner graph $(\mathcal{B}, \mathcal{C}_X, \mathcal{C}_Z, \mathcal{E}_X, \mathcal{E}_Z)$, where $\mathcal{B} = \{1, 2, \dots, n\}$ is the set of bits, $\mathcal{C}_X = \{x_1, x_2, \dots, x_{r_X}\}$ and $\mathcal{C}_Z = \{z_1, z_2, \dots, z_{r_Z}\}$ are sets of checks, and $\mathcal{E}_X \subset \mathcal{B} \times \mathcal{C}_X$ and $\mathcal{E}_Z \subset \mathcal{B} \times \mathcal{C}_Z$ are sets of edges. The bipartite graph $(\mathcal{B}, \mathcal{C}_X, \mathcal{E}_X)$ is the Tanner graph of the check matrix H_X , and the bipartite graph $(\mathcal{B}, \mathcal{C}_Z, \mathcal{E}_Z)$ is the Tanner graph of the check matrix H_Z .

Let $(\mathcal{B}, \mathcal{C}, \mathcal{E})$ be the Tanner graph of a check matrix H . We use $\mathcal{B}(\mathcal{E}, a)$ to denote the subset of bits that are adjacent to the check $a \in \mathcal{C}$, i.e.

$$\mathcal{B}(\mathcal{E}, a) = \{u \in \mathcal{B} \mid (u, a) \in \mathcal{E}\}. \quad (\text{A17})$$

We use $\mathcal{C}(\mathcal{E}, u)$ to denote the subset of checks that are adjacent to the bit $u \in \mathcal{B}$, i.e.

$$\mathcal{C}(\mathcal{E}, u) = \{a \in \mathcal{C} \mid (u, a) \in \mathcal{E}\}. \quad (\text{A18})$$

We use $\mathcal{E}(u)$ to denote the subset of edges that are incident on the bit $u \in \mathcal{B}$, i.e.

$$\mathcal{E}(u) = \{(u, a) \in \mathcal{E}\}. \quad (\text{A19})$$

We use $w_{max}(H)$ to denote the maximum number of non-zero entries in columns and rows of H , the maximum vertex degree of $(\mathcal{B}, \mathcal{C}, \mathcal{E})$.

Supports. We use $\mathcal{Q}(\sigma) \subseteq \mathcal{B}$ to denote the support of the Pauli operator σ , i.e. σ acts non-trivially on and only on qubits in $\mathcal{Q}(\sigma)$. Given a subset of Z logical operators

$$\Sigma = \{\sigma_1, \sigma_2, \dots, \sigma_q\} \subseteq \mathcal{Z}, \quad (\text{A20})$$

the crowd number of a qubit u is

$$cn(\Sigma, u) = \sum_{\sigma \in \Sigma} |\mathcal{Q}(\sigma) \cap \{u\}|. \quad (\text{A21})$$

The union of the supports of all the logical operators in Σ is

$$\mathcal{Q}(\Sigma) = \bigcup_{\sigma \in \Sigma} \mathcal{Q}(\sigma). \quad (\text{A22})$$

A Z logical operator $\tau \in \mathcal{Z}$ is said to be in $\mathcal{Q}(\Sigma)$ if and only if there exist a Z stabiliser operator $Z(h)$ ($h \in \text{rs}H_Z$) and Z gauge operator $Z(f)$ ($f \in \text{rs}F_Z$) such that $\mathcal{Q}[Z(h)Z(f)\tau] \subseteq \mathcal{Q}(\Sigma)$. The Z logical operators in $\mathcal{Q}(\Sigma)$ constitute a group. Let k_N be the number of independent generators of the group, and let q be the number of independent generators of $\langle \Sigma \rangle$. Then, the redundancy number of Σ is $rn(\Sigma) = k_N - q$. We can compute the redundancy number according to Algorithm 4, in which the rank of G_2 is the redundancy number of Σ .

Standard form. We say a generator matrix is in the standard form if and only if the matrix is in the form $J = \begin{pmatrix} E & J' \end{pmatrix}$ up to permutations of rows and columns. We can always obtain a generator matrix in the standard form through Gaussian elimination.

Appendix B: Glue code

We can simultaneously operate Z logical operators in Σ by attaching a sticker to the memory. The sticker is constructed according to the glue code, which is a binary linear code. In this section, we define the glue code in detail.

1. Compatible glue codes

Definition 1. Compatible glue code. Let $(H_X, H_Z, J_X, J_Z, F_X, F_Z)$ be the code of the memory. Let $H_G \in \mathbb{F}_2^{r_G \times n_G}$ be the check matrix of the glue code. The glue code is said to be compatible with the memory if and only if there exists pasting matrices $S \in \mathbb{F}_2^{n_G \times n}$ and $T \in \mathbb{F}_2^{r_X \times r_G}$ such that

$$H_X S^T = T H_G. \quad (\text{B1})$$

As an example, we consider an X -operator check matrix in the form

$$H_X = \begin{pmatrix} H_N & A_X \\ 0_{(r_X - r_N) \times n_N} & B_X \end{pmatrix}. \quad (\text{B2})$$

Then, the glue code

$$H_G = \begin{pmatrix} H_N & 0_{r_N \times (n_G - n_N)} \\ A_G & B_G \end{pmatrix} \quad (\text{B3})$$

is compatible with the memory. By taking pasting matrices

$$S = \begin{pmatrix} E_{n_N} & 0_{n_N \times (n - n_N)} \\ 0_{(n_G - n_N) \times n_N} & 0_{(n_G - n_N) \times (n - n_N)} \end{pmatrix}, \quad (\text{B4})$$

$$T = \begin{pmatrix} E_{r_N} & 0_{r_N \times (r_G - r_N)} \\ 0_{(r_X - r_N) \times r_N} & 0_{(r_X - r_N) \times (r_G - r_N)} \end{pmatrix}, \quad (\text{B5})$$

we have

$$H_X S^T = T H_G = \begin{pmatrix} H_N & 0_{r_N \times (n_G - n_N)} \\ 0_{(r_X - r_N) \times n_N} & 0_{(r_X - r_N) \times (n_G - n_N)} \end{pmatrix}. \quad (\text{B6})$$

Lemma 1. *If the glue code is compatible with the memory, $(\ker H_G)S \subseteq \ker H_X$.*

Proof. For all $u \in \ker H_G$, $T H_G u^T = 0$. Then, $H_X S^T u^T = 0$, i.e. $uS \in \ker H_X$. \square

2. Glue codes devised for Σ

The operation realised by a sticker is determined by the glue code. To operate logical operators in Σ , we need to construct a compatible glue code, and the code also needs to meet Σ .

Definition 2. Devised glue codes. Let $v_1, v_2, \dots, v_q \in \text{rs}(J_Z)$ be vectors corresponding to the operator set Σ , i.e. $Z(v_i) = \sigma_i$ for $i = 1, 2, \dots, q$. Let H_G be the check matrix of a glue code that is compatible with the memory. The glue code is said to be **coarsely devised** for Σ if and only if

$$\text{span}(v_1, v_2, \dots, v_q) \subseteq (\ker H_G)S. \quad (\text{B7})$$

The glue code is said to be **finely devised** for Σ if and only if there exists $u_1, u_2, \dots \in \text{rs}H_Z \oplus \text{rs}F_Z$ such that

$$\text{span}(v_1, v_2, \dots, v_q, u_1, u_2, \dots) = (\ker H_G)S. \quad (\text{B8})$$

We will give a systemic approach for constructing devised glue codes in Sec. G.

Vectors $\{v_1, v_2, \dots, v_q\}$ span a subspace $\text{rs}J_{Z,A}$, where

$$J_{Z,A} = \begin{pmatrix} v_1 \\ v_2 \\ \vdots \\ v_q \end{pmatrix}. \quad (\text{B9})$$

Then, all logical operators in $Z(\text{rs}J_{Z,A}) = \langle \Sigma \rangle$ are actively operated by the sticker. Without loss of generality, we suppose that $\{v_1, v_2, \dots, v_q\}$ are linearly independent. Then, we can find a basis of $\text{rs}J_Z$ by extending $\{v_1, v_2, \dots, v_q\}$, denoted by

$$\{v_1, v_2, \dots, v_q\} \cup \{v_{q+1}, v_{q+2}, \dots, v_k\}. \quad (\text{B10})$$

Vectors $\{v_{q+1}, v_{q+2}, \dots, v_k\}$ span the complementary subspace $\text{rs}J_{Z,C}$, where

$$J_{Z,C} = \begin{pmatrix} v_{q+1} \\ v_{q+2} \\ \vdots \\ v_k \end{pmatrix}. \quad (\text{B11})$$

Since $\text{rs}J_Z = \text{rs}J_{Z,A} \oplus \text{rs}J_{Z,C}$, there exist a full rank matrix $\bar{J}_Z \in \mathbb{F}_2^{k \times k}$ such that

$$\begin{pmatrix} J_{Z,A} \\ J_{Z,C} \end{pmatrix} = \bar{J}_Z J_Z. \quad (\text{B12})$$

Let $\bar{J}_X = \bar{J}_Z^{-1}$. We have matrices $\bar{J}_{X,A} \in \mathbb{F}_2^{q \times n}$ and $\bar{J}_{X,C} \in \mathbb{F}_2^{(k-q) \times n}$ defined according to

$$\begin{pmatrix} J_{X,A} \\ J_{X,C} \end{pmatrix} = \bar{J}_X J_X. \quad (\text{B13})$$

Then, they satisfy $\text{rs}J_X = \text{rs}J_{X,A} \oplus \text{rs}J_{X,C}$, $J_{X,A}J_{Z,A}^T = E_q$, $J_{X,C}J_{Z,C}^T = E_{k-q}$, and $J_{X,A}J_{Z,C}^T = J_{X,C}J_{Z,A}^T = 0$.

Lemma 2. *If the glue code is finely devised for Σ , there exists $\gamma \in \mathbb{F}_2^{(k-q) \times r_G}$ such that $J_{X,C}S^T = \gamma H_G$.*

Proof. According to Definition 2, there exists a matrix K_Z and a generator matrix of the glue code $\ker H_G$, denoted by G , satisfying $\text{rs}K_Z \subseteq \text{rs}H_Z \oplus \text{rs}F_Z$ and

$$\begin{pmatrix} J_{Z,A} \\ K_Z \end{pmatrix} = GS. \quad (\text{B14})$$

Then, $J_{X,C}S^T G^T = 0$. Therefore, $\text{rs}(J_{X,C}S^T) \subseteq \ker G = \text{rs}H_G$. \square

Appendix C: Stickers

In this section, we define the two types of stickers, measurement stickers and branch stickers.

Definition 3. Measurement stickers. A measurement sticker is a hypergraph product code generated by check matrices H_G and $\lambda_{d_R}^T$, where H_G is the check matrix of the glue code. The X - and Z -operator check matrices of the measurement sticker are

$$H_X^M = (H_G \otimes E_{d_R-1} \ E_{r_G} \otimes \lambda_{d_R}), \quad (\text{C1})$$

$$H_Z^M = (E_{n_G} \otimes \lambda_{d_R}^T \ H_G^T \otimes E_{d_R}). \quad (\text{C2})$$

For the convenience of subsequent discussions, we expand measurement-sticker check matrices in the form

$$H_X^M = \begin{pmatrix} H_G & 0 & \cdots & 0 & 0 & E_{r_G} & E_{r_G} & 0 & \cdots & 0 & 0 & 0 \\ 0 & H_G & \cdots & 0 & 0 & 0 & E_{r_G} & E_{r_G} & \cdots & 0 & 0 & 0 \\ \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots \\ 0 & 0 & \cdots & H_G & 0 & 0 & 0 & 0 & \cdots & E_{r_G} & E_{r_G} & 0 \\ 0 & 0 & \cdots & 0 & H_G & 0 & 0 & 0 & \cdots & 0 & E_{r_G} & E_{r_G} \end{pmatrix}, \quad (\text{C3})$$

and

$$H_Z^M = \begin{pmatrix} E_{n_G} & 0 & \cdots & 0 & 0 & H_G^T & 0 & 0 & \cdots & 0 & 0 & 0 \\ E_{n_G} & E_{n_G} & \cdots & 0 & 0 & 0 & H_G^T & 0 & \cdots & 0 & 0 & 0 \\ 0 & E_{n_G} & \cdots & 0 & 0 & 0 & 0 & H_G^T & \cdots & 0 & 0 & 0 \\ \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots \\ 0 & 0 & \cdots & E_{n_G} & 0 & 0 & 0 & 0 & \cdots & H_G^T & 0 & 0 \\ 0 & 0 & \cdots & E_{n_G} & E_{n_G} & 0 & 0 & 0 & \cdots & 0 & H_G^T & 0 \\ 0 & 0 & \cdots & 0 & E_{n_G} & 0 & 0 & 0 & \cdots & 0 & 0 & H_G^T \end{pmatrix}. \quad (\text{C4})$$

Definition 4. Branch stickers. A branch sticker is a hypergraph product code generated by check matrices H_G and $\lambda_{d_R; \bullet, 1: d_R-1}^T$, where H_G is the check matrix of the glue code. The X - and Z -operator check matrices of the branch sticker are

$$H_X^B = (H_G \otimes E_{d_R-1} \ E_{r_G} \otimes \lambda_{d_R; \bullet, 1: d_R-1}), \quad (\text{C5})$$

$$H_Z^B = (E_{n_G} \otimes \lambda_{d_R; \bullet, 1: d_R-1}^T \ H_G^T \otimes E_{d_R-1}). \quad (\text{C6})$$

For the convenience of subsequent discussions, we expand measurement-sticker check matrices in the form

$$H_X^B = \begin{pmatrix} H_G & 0 & \cdots & 0 & 0 & E_{r_G} & E_{r_G} & 0 & \cdots & 0 & 0 \\ 0 & H_G & \cdots & 0 & 0 & 0 & E_{r_G} & E_{r_G} & \cdots & 0 & 0 \\ \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots \\ 0 & 0 & \cdots & H_G & 0 & 0 & 0 & 0 & \cdots & E_{r_G} & E_{r_G} \\ 0 & 0 & \cdots & 0 & H_G & 0 & 0 & 0 & \cdots & 0 & E_{r_G} \end{pmatrix}, \quad (\text{C7})$$

and

$$H_Z^B = \begin{pmatrix} E_{n_G} & 0 & \cdots & 0 & 0 & H_G^T & 0 & 0 & \cdots & 0 & 0 \\ E_{n_G} & E_{n_G} & \cdots & 0 & 0 & 0 & H_G^T & 0 & \cdots & 0 & 0 \\ 0 & E_{n_G} & \cdots & 0 & 0 & 0 & 0 & H_G^T & \cdots & 0 & 0 \\ \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots \\ 0 & 0 & \cdots & E_{n_G} & 0 & 0 & 0 & 0 & \cdots & H_G^T & 0 \\ 0 & 0 & \cdots & E_{n_G} & E_{n_G} & 0 & 0 & 0 & \cdots & 0 & H_G^T \end{pmatrix}. \quad (\text{C8})$$

We can find that H_X^B can be generated by deleting the last column from H_X^M in Eq. (C3), and H_Z^B can be generated by deleting the last column and last row from H_Z^M in Eq. (C4).

Appendix D: Deformed codes

When the glue code of a sticker is compatible with the memory, we can attach the sticker to the memory and generate a deformed code. In this section, we define the deformed codes and their logical operators. We need to define the logical operators because the deformed codes are subsystem codes in general. With logical operators defined, we analyse distances of deformed codes.

1. Definitions

Definition 5. Measurement-sticker deformed codes. Let (H_X, H_Z) be check matrices of the memory. Let H_G be the check matrix of the glue code. Suppose the glue code is compatible with the memory and finely devised for a set of Z logical operators Σ . The deformed code is generated by attaching the corresponding measurement sticker to the memory, and its X - and Z -operator check matrices are

$$H_X^{M-M} = \begin{pmatrix} H_X & 0 & 0 & \cdots & 0 & 0 & T & 0 & 0 & \cdots & 0 & 0 & 0 \\ 0 & H_G & 0 & \cdots & 0 & 0 & E_{r_G} & E_{r_G} & 0 & \cdots & 0 & 0 & 0 \\ 0 & 0 & H_G & \cdots & 0 & 0 & 0 & E_{r_G} & E_{r_G} & \cdots & 0 & 0 & 0 \\ \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots \\ 0 & 0 & 0 & \cdots & H_G & 0 & 0 & 0 & 0 & \cdots & E_{r_G} & E_{r_G} & 0 \\ 0 & 0 & 0 & \cdots & 0 & H_G & 0 & 0 & 0 & \cdots & 0 & E_{r_G} & E_{r_G} \end{pmatrix}, \quad (D1)$$

and

$$H_Z^{M-M} = \begin{pmatrix} H_Z & 0 & 0 & \cdots & 0 & 0 & 0 & 0 & 0 & \cdots & 0 & 0 & 0 \\ S & E_{n_G} & 0 & \cdots & 0 & 0 & H_G^T & 0 & 0 & \cdots & 0 & 0 & 0 \\ 0 & E_{n_G} & E_{n_G} & \cdots & 0 & 0 & 0 & H_G^T & 0 & \cdots & 0 & 0 & 0 \\ 0 & 0 & E_{n_G} & \cdots & 0 & 0 & 0 & 0 & H_G^T & \cdots & 0 & 0 & 0 \\ \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots \\ 0 & 0 & 0 & \cdots & E_{n_G} & 0 & 0 & 0 & 0 & \cdots & H_G^T & 0 & 0 \\ 0 & 0 & 0 & \cdots & E_{n_G} & E_{n_G} & 0 & 0 & 0 & \cdots & 0 & H_G^T & 0 \\ 0 & 0 & 0 & \cdots & 0 & E_{n_G} & 0 & 0 & 0 & \cdots & 0 & 0 & H_G^T \end{pmatrix}. \quad (D2)$$

Definition 6. Branch-sticker deformed codes. Let (H_X, H_Z) be check matrices of the memory. Let H_G be the check matrix of the glue code. Suppose the glue code is compatible with the memory. The deformed code is generated by attaching the corresponding branch sticker to the memory, and its X - and Z -operator check matrices are

$$H_X^{M-B} = \begin{pmatrix} H_X & 0 & 0 & \cdots & 0 & 0 & T & 0 & 0 & \cdots & 0 & 0 \\ 0 & H_G & 0 & \cdots & 0 & 0 & E_{r_G} & E_{r_G} & 0 & \cdots & 0 & 0 \\ 0 & 0 & H_G & \cdots & 0 & 0 & 0 & E_{r_G} & E_{r_G} & \cdots & 0 & 0 \\ \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots \\ 0 & 0 & 0 & \cdots & H_G & 0 & 0 & 0 & 0 & \cdots & E_{r_G} & E_{r_G} \\ 0 & 0 & 0 & \cdots & 0 & H_G & 0 & 0 & 0 & \cdots & 0 & E_{r_G} \end{pmatrix}, \quad (D3)$$

and

$$H_Z^{M-B} = \begin{pmatrix} H_Z & 0 & 0 & \cdots & 0 & 0 & 0 & 0 & 0 & \cdots & 0 & 0 \\ S & E_{n_G} & 0 & \cdots & 0 & 0 & H_G^T & 0 & 0 & \cdots & 0 & 0 \\ 0 & E_{n_G} & E_{n_G} & \cdots & 0 & 0 & 0 & H_G^T & 0 & \cdots & 0 & 0 \\ 0 & 0 & E_{n_G} & \cdots & 0 & 0 & 0 & 0 & H_G^T & \cdots & 0 & 0 \\ \vdots & \vdots & \vdots & \ddots & \vdots & \vdots & \vdots & \vdots & \vdots & \ddots & \vdots & \vdots \\ 0 & 0 & 0 & \cdots & E_{n_G} & 0 & 0 & 0 & 0 & \cdots & H_G^T & 0 \\ 0 & 0 & 0 & \cdots & E_{n_G} & E_{n_G} & 0 & 0 & 0 & \cdots & 0 & H_G^T \end{pmatrix}. \quad (D4)$$

Proposition 1. As a consequence of Eq. (B1) in Definition 1, check matrices of deformed codes are compatible, i.e. $H_X^{M-M} H_Z^{M-M^T} = 0$ and $H_X^{M-B} H_Z^{M-B^T} = 0$.

2. Logical operators

Definition 7. Logical operators of measurement-sticker deformed codes. For a measurement-sticker deformed code as defined in Definition 5, its X - and Z -operator generator matrices are

$$J_X^{M-M} = (J_{X,C} \ J_{X,C}S^T \ J_{X,C}S^T \ \cdots \ J_{X,C}S^T \ J_{X,C}S^T \ 0 \ 0 \ 0 \ \cdots \ 0 \ 0 \ \gamma), \quad (\text{D5})$$

and

$$J_Z^{M-M} = (J_{Z,C} \ 0 \ 0 \ \cdots \ 0 \ 0 \ 0 \ 0 \ \cdots \ 0 \ 0 \ 0). \quad (\text{D6})$$

Definition 8. Logical operators of branch-sticker deformed codes. For a branch-sticker deformed code as defined in Definition 6, its X - and Z -operator generator matrices are

$$J_X^{M-B} = \begin{pmatrix} J_{X,A} & J_{X,A}S^T & J_{X,A}S^T & \cdots & J_{X,A}S^T & J_{X,A}S^T & 0 & 0 & 0 & \cdots & 0 & 0 \\ J_{X,C} & J_{X,C}S^T & J_{X,C}S^T & \cdots & J_{X,C}S^T & J_{X,C}S^T & 0 & 0 & 0 & \cdots & 0 & 0 \end{pmatrix}, \quad (\text{D7})$$

and

$$J_Z^{M-B} = \begin{pmatrix} J_{Z,A} & 0 & 0 & \cdots & 0 & 0 & 0 & 0 & \cdots & 0 & 0 \\ J_{Z,C} & 0 & 0 & \cdots & 0 & 0 & 0 & 0 & \cdots & 0 & 0 \end{pmatrix}. \quad (\text{D8})$$

Proposition 2. As a consequence of Lemma 2, generator matrices of measurement-sticker deformed codes are valid, i.e. $H_X^{M-M} J_Z^{M-MT} = H_Z^{M-M} J_X^{M-MT} = 0$ and $J_X^{M-M} J_Z^{M-MT} = E_{k-q}$. Generator matrices of branch-sticker deformed codes are valid, i.e. $H_X^{M-B} J_Z^{M-BT} = H_Z^{M-B} J_X^{M-BT} = 0$ and $J_X^{M-B} J_Z^{M-BT} = E_k$.

3. Code distances

Lemma 3. Let the distance of the memory be d . The distance of the measurement-sticker deformed code has the lower bound

$$d^{M-M} \geq \min\{d/|S|, d_R\}. \quad (\text{D9})$$

Here, $|S|$ denotes the matrix norm induced by the Hamming weight, where S acts on the vector from the right side.

Proof. X-operator distance. We prove the distance lower bound by contradiction. Suppose that there exists a Z logical error e , i.e. $H_X^{M-M} e^T = 0$ and $J_X^{M-M} e^T \neq 0$, but its weight is $|e| < \min\{d/|S|, d_R\}$. Let the error be

$$e = (u_0 \ u_1 \ u_2 \ \cdots \ u_{d_R-2} \ u_{d_R-1} \ v_1 \ v_2 \ v_3 \ \cdots \ v_{d_R-1} \ v_{d_R}). \quad (\text{D10})$$

As a consequence of $H_X^{M-M} e^T = 0$, the following equations hold,

$$H_X u_0^T = T v_1^T, \quad (\text{D11})$$

$$H_G u_j^T = v_j^T + v_{j+1}^T, \quad (\text{D12})$$

where $j = 1, 2, \dots, d_R - 1$. Because $|e| < d_R$, one of v_1, v_2, \dots, v_{d_R} must be zero. Suppose $v_l = 0$. According to Eq. (D12),

$$H_G \sum_{j=1}^{l-1} u_j^T = v_1^T. \quad (\text{D13})$$

Substitute v_1^T into Eq. (D11), we have

$$H_X u_0^T = T H_G \sum_{j=1}^{l-1} u_j^T = H_X S^T \sum_{j=1}^{l-1} u_j^T. \quad (\text{D14})$$

Therefore,

$$H_X \left(u_0^T + S^T \sum_{j=1}^{l-1} u_j^T \right) = 0. \quad (\text{D15})$$

As a consequence of $J_X^{M-M} e^T \neq 0$,

$$J_{X,C} u_0^T + J_{X,C} S^T \sum_{j=1}^{d_R-1} u_j^T + \gamma v_{d_R}^T \neq 0. \quad (\text{D16})$$

We consider the term

$$x = J_{X,C} S^T \sum_{j=l}^{d_R-1} u_j^T + \gamma v_{d_R}^T. \quad (\text{D17})$$

According to Lemma 2,

$$x = \gamma \left(H_G \sum_{j=l}^{d_R-1} u_j^T + v_{d_R}^T \right). \quad (\text{D18})$$

Because of Eq. (D12) and $v_l = 0$, $x = 0$. Therefore,

$$J_{X,C} \left(u_0^T + S^T \sum_{j=1}^{l-1} u_j^T \right) \neq 0. \quad (\text{D19})$$

According to Eqs. (D15) and (D19), the error

$$u = u_0 + \left(\sum_{j=1}^{l-1} u_j \right) S \quad (\text{D20})$$

is a logical error of the memory, i.e. $|u| \geq d$. Using inequalities

$$|u| \leq |u_0| + \left(\sum_{j=1}^{l-1} |u_j| \right) |S|, \quad (\text{D21})$$

$$|e| \geq |u_0| + \left(\sum_{j=1}^{l-1} |u_j| \right), \quad (\text{D22})$$

and $|S| \geq 1$ (when $S \neq 0$), we have $|e| \geq |u|/|S| \geq d/|S|$, which is a contradiction.

Z-operator distance. Let e be an X logical error, i.e. $H_Z^{M-M} e^T = 0$ and $J_Z^{M-M} e^T \neq 0$. Expressing e in the form of Eq. (D10), we have

$$H_Z u_0^T = 0, \quad (\text{D23})$$

$$J_{Z,C} u_0^T \neq 0. \quad (\text{D24})$$

Therefore, u_0 is a logical error of the memory, i.e. $|u_0| \geq d$. Then, $|e| \geq |u_0| \geq d$. \square

Lemma 4. *Let the distance of the memory be d . The distance of the branch-sticker deformed code has the lower bound*

$$d^{M-M} \geq d/|S|. \quad (\text{D25})$$

Proof. X-operator distance. The proof is similar to Lemma 3. We remove the entry v_{d_R} from the expression of the error e in Eq. (D10) and take $v_{d_R} = 0$ and $l = d_R$ in the equations. Because we always have $v_{d_R} = 0$, the existence of a zero-valued v_j entry is independent of d_R , i.e. the distance lower bound is independent of d_R .

Z-operator distance. The proof is the same as Lemma 3. \square

Appendix E: Relations between memory operators and deformed-code operators

To establish the relations between memory operators and deformed-code operators, we introduce three matrices representing supports of the memory on the measurement-sticker deformed code, the memory on the branch-sticker deformed code and the open boundary on the branch sticker, respectively. They are

$$P_{M-M} = (E_n \ 0 \ 0 \ \cdots \ 0 \ 0 \ 0 \ 0 \ \cdots \ 0 \ 0 \ 0), \quad (\text{E1})$$

$$P_{M-B} = (E_n \ 0 \ 0 \ \cdots \ 0 \ 0 \ 0 \ 0 \ \cdots \ 0 \ 0) \quad (\text{E2})$$

, and

$$P_{ob} = (0 \ 0 \ 0 \ \cdots \ 0 \ E_{n_c} \ 0 \ 0 \ \cdots \ 0 \ 0). \quad (\text{E3})$$

The matrices $P_{M-M}^T P_{M-M}$, $P_{M-B}^T P_{M-B}$ and $P_{ob}^T P_{ob}$ are projections onto supports of the memory on the measurement-sticker deformed code, the memory on the branch-sticker deformed code and the open boundary on the branch sticker, respectively.

Lemma 5. *For a measurement-sticker deformed code,*

$$\text{rs}H_X = \text{rs}(H_X^{M-M} P_{M-M}^T), \quad (\text{E4})$$

$$\text{rs}(H_Z P_{M-M}) \subseteq \text{rs}H_Z^{M-M}, \quad (\text{E5})$$

$$\text{rs}J_{X,C} = \text{rs}(J_X^{M-M} P_{M-M}^T), \quad (\text{E6})$$

$$\text{rs}(J_{Z,C} P_{M-M}) = \text{rs}J_Z^{M-M}, \quad (\text{E7})$$

$$\text{rs}(J_{Z,A} P_{M-M}) \subseteq \text{rs}H_Z^{M-M}. \quad (\text{E8})$$

Proof. The matrix $H_X^{M-M} P_{M-M}^T$ is the first column of H_X^{M-M} , in which the first row is H_X , and all other rows are zero. Therefore, Eq. (E4) holds. The matrix $H_Z P_{M-M}$ is the first row of H_Z^{M-M} . Therefore, Eq. (E5) holds.

Because $J_{X,C} = J_X^{M-M} P_{M-M}^T$ and $J_{Z,C} P_{M-M} = J_Z^{M-M}$, Eqs. (E6) and (E7) hold.

By taking

$$\beta = (0 \ J_{Z,A} S^g \ J_{Z,A} S^g \ \cdots \ J_{Z,A} S^g \ J_{Z,A} S^g \ 0 \ 0 \ 0 \ \cdots \ 0 \ 0 \ 0), \quad (\text{E9})$$

we have

$$J_{Z,A} P_{M-M} = \beta H_Z^{M-M}. \quad (\text{E10})$$

Here, S^g denotes the generalised inverse of the matrix S , i.e. $S S^g S = S$, and we have used that $J_{Z,A} S^g S = J_{Z,A}$, which is a consequence of the definition of coarsely devised glue codes. Therefore, Eq. (E8) holds. \square

Lemma 6. *For a branch-sticker deformed code,*

$$\text{rs}H_X = \text{rs}(H_X^{M-B} P_{M-B}^T), \quad (\text{E11})$$

$$\text{rs}(H_Z P_{M-B}) \subseteq \text{rs}H_Z^{M-B}, \quad (\text{E12})$$

$$\text{rs}J_X = \text{rs}(J_Z^{M-B} P_{M-B}^T), \quad (\text{E13})$$

$$\text{rs}(J_Z P_{M-B}) = \text{rs}J_Z^{M-B}, \quad (\text{E14})$$

$$\text{rs}(J_{Z,A} P_{M-B} + J_{Z,A} S^g P_{ob}) \subseteq \text{rs}H_Z^{M-B}. \quad (\text{E15})$$

Proof. Eqs. (E11), (E12), (E13) and (E14) are proved as the same as Eqs. (E4), (E5), (E6) and (E7) by noticing that

$$\text{rs} \begin{pmatrix} J_{X,A} \\ J_{X,C} \end{pmatrix} = \text{rs}J_X, \quad (\text{E16})$$

$$\text{rs} \begin{pmatrix} J_{Z,A} \\ J_{Z,C} \end{pmatrix} = \text{rs}J_Z. \quad (\text{E17})$$

By taking β in the form of Eq. (E9) with the last zero-valued entry removed, we have

$$J_{Z,A} P_{M-B} + J_{Z,A} S^g P_{ob} = \beta H_Z^{M-B}. \quad (\text{E18})$$

Therefore, Eq. (E15) holds. \square

Appendix F: Theorem of the generalised lattice surgery

Theorem 3. Let \mathcal{S} and \mathcal{S}_{dc} be stabilisers of the memory and deformed code, respectively. Let \mathcal{X} and \mathcal{X}_{dc} (\mathcal{Z} and \mathcal{Z}_{dc}) be groups of X (Z) logical operators of the memory and deformed code, respectively. Let the distance of the memory be d . The following statements hold,

- i) For each X stabiliser operator of the memory (deformed code) $g \in \mathcal{S}$ ($g_{dc} \in \mathcal{S}_{dc}$), there exists an X stabiliser operator of the deformed code (memory) $g_{dc} \in \mathcal{S}_{dc}$ ($g \in \mathcal{S}$) such that the support of gg_{dc} is on the sticker;
- ii) For each Z stabiliser operator of the memory $g \in \mathcal{S}$, there exists a Z stabiliser operator of the deformed code $g_{dc} \in \mathcal{S}_{dc}$ such that $g = g_{dc}$.

If the deformed code is generated by a measurement sticker,

- iii) For each X logical operator of the memory $\tau \in \mathcal{X}$ that commutes with operators in $\langle \Sigma \rangle$, there exists an X logical operator of the deformed code $\tau_{dc} \in \mathcal{X}_{dc}$ such that the support of $\tau\tau_{dc}$ is on the sticker;
- iv) For each Z logical operator of the memory $\tau \in \mathcal{Z}$, there exists a Z logical operator of the deformed code $\tau_{dc} \in \mathcal{Z}_{dc}$ and a Z stabiliser operator of the deformed code $g_{dc} \in \mathcal{S}_{dc}$ such that $\tau = \tau_{dc}g_{dc}$;
- v) For each Z logical operator of the memory $\tau \in \langle \Sigma \rangle$, there exists a Z stabiliser operator of the deformed code $g_{dc} \in \mathcal{S}_{dc}$ such that $\tau = g_{dc}$;
- vi) The distance of the deformed code is $d_{dc} \geq \min\{d/|S|, d_R\}$.

If the deformed code is generated by a branch sticker,

- iii') For each X logical operator of the memory $\tau \in \mathcal{X}$, there exists an X logical operator of the deformed code $\tau_{dc} \in \mathcal{X}_{dc}$ such that the support of $\tau\tau_{dc}$ is on the sticker;
- iv') For each Z logical operator of the memory $\tau \in \mathcal{Z}$, there exists a Z logical operator of the deformed code $\tau_{dc} \in \mathcal{Z}_{dc}$ such that $\tau = \tau_{dc}$;
- v') For each Z logical operator of the memory $\tau \in \langle \Sigma \rangle$, there exists a Z stabiliser operator of the deformed code $g_{dc} \in \mathcal{S}_{dc}$ such that the support of τg_{dc} is on the open boundary of the branch sticker;
- vi') The distance of the deformed code is $d_{dc} \geq d/|S|$.

Proof. We have proved every piece of the theorem in Lemmas 3, 4, 5 and 6. Here, we only need to relate these lemmas to statements in the theorem.

Let \mathcal{S}^X and \mathcal{S}^Z (\mathcal{S}_{dc}^X and \mathcal{S}_{dc}^Z) be the sets of X and Z stabiliser operators of the memory (deformed code), respectively. These operator sets are related to check and generator matrices through $\mathcal{S}^X = X(\text{rs}H_X)$, $\mathcal{S}^Z = Z(\text{rs}H_Z)$, $\mathcal{S}_{dc}^X = X(\text{rs}H_X^{M-\alpha})$ and $\mathcal{S}_{dc}^Z = Z(\text{rs}H_Z^{M-\alpha})$, where $\alpha = M, D$. Therefore, statements i) and ii) are consequences of Eqs. (E4), (E5), (E11) and (E12).

The set of memory X logical operators that commute with operators in Σ is $X(\text{rs}J_{X,C})$. Therefore, the statement iii) is a consequence of Eq. (E6).

According to Eqs. (E7) and (E8),

$$\text{rs}(J_Z P_{M-M}) \subseteq \text{rs} \begin{pmatrix} H_Z^{M-M} \\ J_Z^{M-M} \end{pmatrix}. \quad (\text{F1})$$

Because $\mathcal{Z} = Z(\text{rs}J_Z)$, $\mathcal{S}_{dc}^Z = Z(\text{rs}H_Z^{M-M})$ and $\mathcal{Z}_{dc} = Z(\text{rs}J_Z^{M-M})$, the statement iv) holds.

Because $\langle \Sigma \rangle = Z(\text{rs}J_{Z,A})$, the statement v) holds according to Eq. (E8).

Similarly, statements iii') and iv') corresponding to Eqs. (E13) and (E14), respectively. The statement v') corresponds to Eq. (E15).

Statements vi) and vi') correspond to Lemmas 3 and 4, respectively. \square

Algorithm 1 BitDuplication($\mathcal{B}, \mathcal{C}, \mathcal{E}, u, \mathcal{C}_u$)

```

1:  $\mathcal{B}' \leftarrow \mathcal{B} \cup \{u'\}$ 
2:  $\mathcal{C}' \leftarrow \mathcal{C} \cup \{a'\}$ 
3:  $\mathcal{E}' \leftarrow \mathcal{E} \cup \{(u, a'), (u', a')\}$ 
4: for  $a \in \mathcal{C}_u$  do
5:    $\mathcal{E}' \leftarrow (\mathcal{E}' - \{u, a\}) \cup \{(u', a)\}$ 
6: Output the Tanner graph  $(\mathcal{B}', \mathcal{C}', \mathcal{E}')$ .

```

Algorithm 2 CheckDuplication($\mathcal{B}, \mathcal{C}, \mathcal{E}, a, \mathcal{B}_a$)

```

1:  $\mathcal{B}' \leftarrow \mathcal{B} \cup \{u'\}$ 
2:  $\mathcal{C}' \leftarrow \mathcal{C} \cup \{a'\}$ 
3:  $\mathcal{E}' \leftarrow \mathcal{E} \cup \{(u', a), (u', a')\}$ 
4: for  $u \in \mathcal{B}_a$  do
5:    $\mathcal{E}' \leftarrow (\mathcal{E}' - \{u, a\}) \cup \{(u, a')\}$ 
6: Output the Tanner graph  $(\mathcal{B}', \mathcal{C}', \mathcal{E}')$ .

```

Appendix G: Theorem of sticking

Theorem 4. Let (H_X, H_Z) be the check matrices of the memory. For an arbitrary set of Z logical operators Σ , there exists a glue code $H_G \in \mathbb{F}_2^{n_G \times n_G}$ that satisfies *i*) the pasting matrices S and T satisfy $w_{max}(S) = w_{max}(T) = 1$;

ii) the glue code is coarsely devised for Σ and

$$n_G = n_N, \quad (\text{G1})$$

$$r_G \leq w_{max}(H_X)n_N, \quad (\text{G2})$$

$$w_{max}(H_G) \leq w_{max}(H_X); \quad (\text{G3})$$

ii') the glue code is finely devised for Σ and

$$n_G \leq n_N + 2(k_N - q)q, \quad (\text{G4})$$

$$r_G \leq w_{max}(H_X)n_N + 2(k_N - q)q, \quad (\text{G5})$$

$$w_{max}(H_G) \leq \max\{w_{max}(H_X) + 1, 3\}. \quad (\text{G6})$$

Here, n_N is the number of qubits on the support of Σ , and k_N is the number of independent Z logical operators on the support of Σ , and q is the number of independent Z logical operators in Σ .

When $w_{max}(S) = 1$, we always have $|S| = 1$.

1. Graph operations

To construct a finely devised glue code, we use two operations on Tanner graphs, bit duplication and check duplication. These two operations are given in Algorithms 1 and 2, respectively, and illustrated in Fig. 7. In the bit duplication operation, we duplicate the bit u on the Tanner graph $(\mathcal{B}, \mathcal{C}, \mathcal{E})$ by adding a new bit u' and a check a' ;

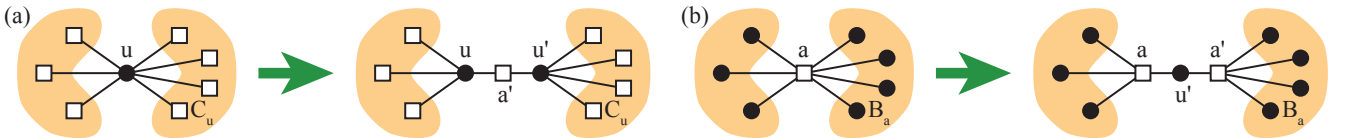


FIG. 7. (a) Bit duplication. (b) Check duplication.

Algorithm 3 Generation of the naked glue code.

- 1: Input $(\mathcal{B}, \mathcal{C}_X, \mathcal{E}_X)$ and \mathcal{B}_N .
- 2: Find X -operator checks that are adjacent to bits in \mathcal{B}_N on the graph $(\mathcal{B}, \mathcal{C}_X, \mathcal{E}_X)$, which constitute the set of checks

$$\mathcal{C}_N = \bigcup_{u \in \mathcal{B}_N} \mathcal{C}_X(\mathcal{E}_X, u). \quad (\text{G8})$$

- 3: Find X -operator edges that are incident on bits in \mathcal{B}_N on the graph $(\mathcal{B}, \mathcal{C}_X, \mathcal{E}_X)$, which constitute the set of edges

$$\mathcal{E}_N = \bigcup_{u \in \mathcal{B}_N} \mathcal{E}_X(u). \quad (\text{G9})$$

- 4: Output the Tanner graph $(\mathcal{B}_N, \mathcal{C}_N, \mathcal{E}_N)$.
-

the check a' is coupled to both u and u' ; and a subset of checks that are adjacent to u , denoted by $\mathcal{C}_u \subseteq \mathcal{C}(\mathcal{E}, u)$, are decoupled from u and coupled to u' . Similarly, in the check duplication operation, we duplicate the check a on the Tanner graph $(\mathcal{B}, \mathcal{C}, \mathcal{E})$ by adding a new check a' and a bit u' ; the bit u' is coupled to both a and a' ; and a subset of bits that are adjacent to a , denoted by $\mathcal{B}_a \subseteq \mathcal{B}(\mathcal{E}, a)$, are decoupled from a and coupled to a' . These two operations have properties summarised in the following lemma.

Lemma 7. *Let $(\mathcal{B}', \mathcal{C}', \mathcal{E}')$ be the Tanner graph generated by applying the bit duplication or check duplication on $(\mathcal{B}, \mathcal{C}, \mathcal{E})$. Let $v : \mathcal{B}' \rightarrow \mathbb{F}_2$. The map v is a codeword of $(\mathcal{B}', \mathcal{C}', \mathcal{E}')$ if and only if the following two conditions are satisfied,*

i) v on the domain \mathcal{B} is a codeword of $(\mathcal{B}, \mathcal{C}, \mathcal{E})$;

ii) For a bit duplication, $v(u') = v(u)$;

ii') For a check duplication, $v(u') = \sum_{u \in \mathcal{B}_a} v(u)$.

Proof. Bit duplication. The map v is a codeword of $(\mathcal{B}', \mathcal{C}', \mathcal{E}')$ if and only if the following conditions are satisfied: i) $\sum_{u'' \in \mathcal{B}(\mathcal{E}, a)} v(u'') = 0$ for all $a \in \mathcal{C} - \mathcal{C}_u$; ii) $v(u') + \sum_{u'' \in \mathcal{B}(\mathcal{E}, a) - \{u\}} v(u'') = 0$ for all $a \in \mathcal{C}_u$; and iii) $v(u) = v(u')$. Under the condition iii), the condition ii) is satisfied if and only if $\sum_{u'' \in \mathcal{B}(\mathcal{E}, a)} v(u'') = 0$ for all $a \in \mathcal{C}_u$. Then, we can rephrase conditions i) and ii) as $\sum_{u'' \in \mathcal{B}(\mathcal{E}, a)} v(u'') = 0$ for all $a \in \mathcal{C}$, i.e. v on the domain \mathcal{B} is a codeword of $(\mathcal{B}, \mathcal{C}, \mathcal{E})$.

Check duplication. Similarly, the map v is a codeword of $(\mathcal{B}', \mathcal{C}', \mathcal{E}')$ if and only if the following conditions are satisfied: i) $\sum_{u \in \mathcal{B}(\mathcal{E}, a'')} v(u) = 0$ for all $a'' \in \mathcal{C} - \{a\}$; ii) $v(u') + \sum_{u \in \mathcal{B}(\mathcal{E}, a) - \mathcal{B}_a} v(u) = 0$; and iii) $v(u') + \sum_{u \in \mathcal{B}_a} v(u) = 0$. Under the condition iii), the condition ii) is satisfied if and only if $\sum_{u \in \mathcal{B}(\mathcal{E}, a)} v(u) = 0$. Then, we can rephrase conditions i) and ii) as $\sum_{u \in \mathcal{B}(\mathcal{E}, a'')} v(u) = 0$ for all $a'' \in \mathcal{C}$, i.e. v on the domain \mathcal{B} is a codeword of $(\mathcal{B}, \mathcal{C}, \mathcal{E})$. \square

2. Proof of the sicking theorem

Proof. We prove the theorem by constructing the glue codes.

Coarsely devised glue code - Naked glue code. The support of Σ is

$$\mathcal{B}_N = \mathcal{Q}(\Sigma). \quad (\text{G7})$$

Let $(\mathcal{B}, \mathcal{C}_X, \mathcal{E}_X)$ be the Tanner graph of the X -operator check matrix H_X . We construct the coarsely devised glue code according to Algorithm 3, which outputs a Tanner graph $(\mathcal{B}_N, \mathcal{C}_N, \mathcal{E}_N)$. The binary linear code of the output Tanner graph, called naked glue code, is coarsely devised for Σ .

Let H_N be the check matrix of the naked glue code. Without loss of generality, we suppose that bits in \mathcal{B}_N are the first $n_N = |\mathcal{B}_N|$ bits in \mathcal{B} , and checks in \mathcal{C}_N are the first $r_N = |\mathcal{C}_N|$ checks in \mathcal{C}_X . Then, H_X is in the form

$$H_X = \begin{pmatrix} H_N & A_X \\ 0_{(r_X - r_N) \times n_N} & B_X \end{pmatrix}. \quad (\text{G10})$$

Algorithm 4 Generation of the dressing matrix.

- 1: Input $J_{Z,A} \in \mathbb{F}_2^{q \times n}$, $J_{Z,C} \in \mathbb{F}_2^{(k-q) \times n}$, $H_N \in \mathbb{F}_2^{r_N \times n_N}$ and $S_N \in \mathbb{F}_2^{n_N \times n}$.
2: Find a basis of $(\ker H_N)S_N \cap (\text{rs}H_Z \oplus \text{rs}F_Z)$, denoted by $\{u_1, u_2, \dots\}$.

3: $G_0 \leftarrow \begin{pmatrix} u_1 \\ u_2 \\ \vdots \end{pmatrix} S_N^T$ $\triangleright \text{rs}G_0 \subseteq \ker H_N$

4: $G_1 \leftarrow J_{Z,A} S_N^T$ $\triangleright \text{rs}G_1 \subseteq \ker H_N$

- 5: Take rows in G_0 and G_1 as basis vectors of $\ker H_N$ and complete the basis with vectors $\{w_1, w_2, \dots\}$.

6: $G_2 \leftarrow \begin{pmatrix} w_1 \\ w_2 \\ \vdots \end{pmatrix}$ $\triangleright \begin{pmatrix} G_0 \\ G_1 \\ G_2 \end{pmatrix}$ is the generator matrix of the code $\ker H_N$.

- 7: Rewrite the matrix $\begin{pmatrix} G_1 \\ G_2 \end{pmatrix}$ in the standard form

$$G_3 = (E_{k_N} \ \cdots) \pi \tag{G15}$$

through Gaussian elimination, where $k_N = n_N - \text{rank}H_N - \text{rank}G_0$, and π is a permutation matrix.

8: $\bar{G}_1 \leftarrow G_1 \pi^T (E_{k_N} \ 0_{k_N \times (n_N - k_N)})^T$

- 9: Compute \bar{D} the generator matrix of the code $\ker \bar{G}_1$ in the standard form.

10: Output $D = (\bar{D} \ 0) \pi$.

In the general case, H_X can always be transformed into the above form through permutations of rows and columns. For the naked glue code, the corresponding pasting matrices are

$$S_N = (E_{n_N} \ 0_{n_N \times (n - n_N)}), \tag{G11}$$

$$T_N = \begin{pmatrix} E_{r_N} \\ 0_{(r_X - r_N) \times r_N} \end{pmatrix}. \tag{G12}$$

Because $H_X S_N^T = T_N H_N$, the naked glue code is compatible with the memory.

Now, we prove that the naked glue code is coarsely devised for Σ . Because the support of Σ is \mathcal{B}_N , $J_{Z,A} S_N^T S_N = J_{Z,A}$. Using $T_N^T H_X S_N^T = H_N$, we have $H_N S_N J_{Z,A}^T = T_N^T H_X S_N^T S_N J_{Z,A}^T = T_N^T H_X J_{Z,A}^T = 0$. Therefore, $(\text{rs}J_{Z,A}) S_N^T \subseteq \ker H_N$, i.e. $\text{rs}J_{Z,A} = (\text{rs}J_{Z,A}) S_N^T S_N \subseteq (\ker H_N) S_N$. According to the Definition 2, the naked glue code is coarsely devised.

Taking $H_G = H_N$, we have $n_G = n_N = |\mathcal{B}_N|$. Because $|\mathcal{C}_X(\mathcal{E}_X, u)| \leq w_{\max}(H_X)$, the number of checks $r_G = r_N = |\mathcal{C}_N| \leq w_{\max}(H_X) |\mathcal{B}_N|$. The Tanner graph $(\mathcal{B}_N, \mathcal{C}_N, \mathcal{E}_N)$ is a subgraph of $(\mathcal{B}, \mathcal{C}_X, \mathcal{E}_X)$, therefore, $w_{\max}(H_G) = w_{\max}(H_N) \leq w_{\max}(H_X)$.

Finely devised glue code - Dressed glue code. To construct a finely devised glue code, we consider a check matrix in the form

$$H_D = \begin{pmatrix} H_N \\ D \end{pmatrix}, \tag{G13}$$

where the dressing matrix D is taken according to Algorithm 4. By taking pasting matrices S_N and

$$T_D = \begin{pmatrix} E_{r_N} & 0_{r_N \times (k_N - q)} \\ 0_{(r_X - r_N) \times r_N} & 0_{(r_X - r_N) \times (k_N - q)} \end{pmatrix}, \tag{G14}$$

we can find that $H_X S_N^T = T_D H_D$. Therefore, such a code is always compatible with the memory. We call it dressed glue code.

The dressed glue code is finely devised for Σ . According to Algorithm 4, $DG_1^T = \bar{D}\bar{G}_1^T = 0$. Let $\bar{G}_2 = G_2 \pi^T (E_{k_N} \ 0)^T$. Then, $DG_2^T = \bar{D}\bar{G}_2^T$. Because $\bar{D}\bar{v} \neq 0$ for all $\bar{v} \in \text{rs}\bar{G}_2 - \{0\}$, $Dv \neq 0$ for all $v \in G_2 - \{0\}$. Therefore, the dressing matrix removes basis vectors of $\text{rs}\bar{G}_2$ from the basis of $\ker H_D$, i.e. the generator matrix of the dressed glue code is in the form

$$\begin{pmatrix} G'_0 \\ G_1 \end{pmatrix}, \tag{G16}$$

Algorithm 5 Generation of the finely devised LDPC glue code.

```

1: Input  $\mathcal{B}_N, \mathcal{C}_N, \mathcal{E}_N, \mathcal{C}_D, \mathcal{E}_D$ .
2:  $\mathcal{B}_G \leftarrow \mathcal{B}_N$ 
3:  $\mathcal{C}_G \leftarrow \mathcal{C}_N \cup \mathcal{C}_D$ 
4:  $\mathcal{E}_G \leftarrow \mathcal{E}_N \cup \mathcal{E}_D$ 
5: for  $u \in \mathcal{B}_N$  do
6:   while  $|\mathcal{C}_G(\mathcal{E}_G, u) - \mathcal{C}_N(\mathcal{E}_N, u)| > 1$  do
7:     Choose  $a, a' \in \mathcal{C}_G(\mathcal{E}_G, u) - \mathcal{C}_N(\mathcal{E}_N, u)$ .
8:      $(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G) \leftarrow \text{BitDuplication}(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G, u, \{a, a'\})$ .
9:   for  $a \in \mathcal{C}_N$  do
10:    while  $|\mathcal{B}_G(\mathcal{E}_G, a) - \mathcal{B}_N(\mathcal{E}_N, a)| > 1$  do
11:      Choose  $u, u' \in \mathcal{B}_G(\mathcal{E}_G, a) - \mathcal{B}_N(\mathcal{E}_N, a)$ .
12:       $(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G) \leftarrow \text{CheckDuplication}(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G, a, \{u, u'\})$ .
13: Output the Tanner graph  $(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G)$ .

```

where $\text{rs}G'_0 \subseteq \text{rs}G_0$. Noticing the definitions of G_0 and G_1 , we have proved that the dressed glue code is finely devised.

Finely devised LDPC glue code. The dressed glue code may not satisfy the LDPC condition. Now, we generate an LDPC glue code from the dressed glue code, which is finely devised.

Let $(\mathcal{B}_N, \mathcal{C}_N, \mathcal{E}_N)$ and $(\mathcal{B}_N, \mathcal{C}_D, \mathcal{E}_D)$ be Tanner graphs of the naked glue code and dressing matrix D , respectively. Then the Tanner graph of the dressed glue code is $(\mathcal{B}_N, \mathcal{C}_N \cup \mathcal{C}_D, \mathcal{E}_N \cup \mathcal{E}_D)$. We generate the LDPC glue code by applying the bit duplication and check duplication operations on the Tanner graph according to Algorithm 5. On the generated Tanner graph $(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G)$, the vertex degrees of bits $u \in \mathcal{B}_N$ (checks $a \in \mathcal{C}_N$) are not larger than $w_{\max}(H_N) + 1$, the vertex degrees of bits (checks) added in bit (check) duplication operations are three, and the vertex degrees of bits (checks) added in check (bit) duplication operations are two. Let H_G be the check matrix of $(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G)$. Then, $w_{\max}(H_G) \leq \max\{w_{\max}(H_N) + 1, 3\}$.

Now, we prove that the LDPC glue code $(\mathcal{B}_G, \mathcal{C}_G, \mathcal{E}_G)$ is a finely devised for Σ . Its check matrix is in the form

$$H_G = \begin{pmatrix} H_N & 0 \\ A_G & B_G \end{pmatrix}. \quad (\text{G17})$$

By taking pasting matrices

$$S = \begin{pmatrix} E_{n_N} & 0_{n_N \times (n - n_N)} \\ 0 & 0 \end{pmatrix}, \quad (\text{G18})$$

$$T = \begin{pmatrix} E_{r_N} & 0 \\ 0_{(r_X - r_N) \times r_N} & 0 \end{pmatrix}, \quad (\text{G19})$$

we can find that $H_X S^T = T H_G$. Therefore, the code is always compatible with the memory. According to Lemma 7, $(\ker H_G)S = (\ker H_D)S_N$. In the proof for the dressed glue code, we have proved that $\text{rs}J_{Z,A} = (\ker H_D)S_N$. Then, $\text{rs}J_{Z,A} = (\ker H_G)S$, i.e. the LDPC glue code is finely devised.

In bit duplication operations, the number of bits (checks) added to the Tanner graph is

$$\sum_{u \in \mathcal{B}_N} \max\{0, |\mathcal{C}_D(\mathcal{E}_D, u)| - 1\} \leq (k_N - q)q. \quad (\text{G20})$$

In check duplication operations, the number of bits (checks) added to the Tanner graph is

$$\sum_{a \in \mathcal{C}_D} \max\{0, |\mathcal{B}_N(\mathcal{E}_D, a)| - 1\} \leq (k_N - q)q. \quad (\text{G21})$$

Here, we have used that \bar{D} is in the standard form. □

Appendix H: General Pauli measurements and universal quantum computing

In addition to Z logical operators, we can also measure X logical operators in a similar way. Suppose there are ancilla logical qubits encoded in a block independent from the memory, we can also measure logical operators in the

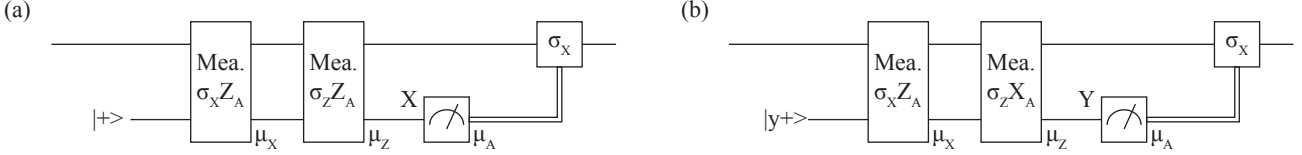


FIG. 8. Circuits for measurements of general logical Pauli operators.

from $\sigma_M \sigma_A$, where σ_M (σ_A) is an X or Z logical operator of the memory (ancilla block). Notice that σ_M and σ_A could be different in the X/Z species.

For a general logical Pauli operator σ , we can measure it in the following way. We write the Pauli operator in the form $\sigma = \nu \sigma_X \sigma_Z$, where $\nu = 1, i$, and σ_X (σ_Z) is an X (Z) logical operator. Let X_A, Y_A, Z_A be the X, Y, Z operators of an ancilla logical qubit, respectively. We measure σ using the ancilla logical qubit.

If $[\sigma_X, \sigma_Z] = 0$, we measure σ according to Fig. 8(a): first, we initialise the ancilla logical qubit in the state $|+\rangle$; then, we measure $\sigma_X Z_A, \sigma_Z Z_A$ and X_A . Let μ_X, μ_Z, μ_A be outcomes of three measurements, respectively. The measurement outcome of σ is $\mu_X \mu_Z$. When $\mu_A = -1$, we apply a correction gate σ_X .

If $\{\sigma_X, \sigma_Z\} = 0$, we measure σ according to Fig. 8(b): first, we initialise the ancilla logical qubit in the state $|y+\rangle$; then, we measure $\sigma_X Z_A, \sigma_Z X_A$ and Y_A . Let μ_X, μ_Z, μ_A be outcomes of three measurements, respectively. The measurement outcome of σ is $\mu_X \mu_Z$. When $\mu_A = -1$, we apply a correction gate σ_X .

We can measure an arbitrary set of commutative logical operators $\{\sigma_1 = \nu_1 \sigma_{1,X} \sigma_{1,Z}, \sigma_2 = \nu_2 \sigma_{2,X} \sigma_{2,Z}, \dots\}$. Consider that we have two ancilla blocks $A0$ and $A1$, in which $A0$ is used for implementing measurements with $[\sigma_X, \sigma_Z] = 0$, and $A1$ is used for implementing measurements with $\{\sigma_X, \sigma_Z\} = 0$. Then, we can measure the operation set in four steps,

1. Initialise ancilla logical qubits in $A0$ in the state $|+\rangle$ and ancilla logical qubits in $A1$ in the state $|y+\rangle$;
2. Apply the joint measurements on σ_X operators and corresponding ancilla logical qubits using the devised sticking protocol or brute-force branching protocol;
3. Apply the joint measurements on σ_Z operators and corresponding ancilla logical qubits using the devised sticking protocol or brute-force branching protocol;
4. Measure ancilla logical qubits in $A0$ in the basis X and ancilla logical qubits in $A1$ in the basis Y .

For a quantum LDPC code, we can initialise logical qubits in a block in the state $|+\rangle$ with a time cost independent of the logical qubit number in the block, and the time cost for the measurement in the basis X is also independent of the logical qubit number in the block. If we choose a code with transversal S gate for $A1$, the initialisation in the state $|y+\rangle$ and measurement in the basis Y can also be accomplished in time independent of the logical qubit number in the block; see Sec. H1 for a discussion on the general case. Using devised sticking or brute-force branching to implement the joint measurements, the time cost is independent of the size of the operator set. Overall, we can measure the operator set in time independent of the size of the operator set.

1. Universal quantum computing and magic state duplication

With measurements on X and Z logical operators, we can realise the logical controlled-NOT gate [13]; using measurements with $[\sigma_X, \sigma_Z] = 0$, we can realise the logical Hadamard gate: to apply the gate on logical qubit-1, we prepare logical qubit-2 in the state $|0\rangle$, apply the measurement $\bar{Z}_1 \bar{X}_2$ on two logical qubits and measure logical qubit-1 in the X basis; these operations transfer the state of logical qubit-1 to logical qubit-2 with the basis rotated. With the logical controlled-NOT gate and Hadamard gate, we can distil $|y+\rangle$ magic states and realise the logical S gate; with these logical Clifford gates, we can distil the magic state for implementing the logical T gate [3].

If the $A1$ block does not have the transversal S gate, we can realise the initialisation in the state $|y+\rangle$ and measurement in the basis Y in the following way. First, we need another ancilla block $A2$, in which logical qubits are prepared in the distilled $|y+\rangle$ state. Second, we effectively initialise ancilla logical qubits in $A1$ in the state $|y+\rangle$ by applying measurements in the form $-Y_{A1} Y_{A2} = X_{A1} X_{A2} Z_{A1} Z_{A2}$, where X_{A1}, Y_{A1}, Z_{A1} (X_{A2}, Y_{A2}, Z_{A2}) are X, Y, Z operators of a logical qubit in the block $A1$ ($A2$). Because the measurement is of the $[\sigma_X, \sigma_Z] = 0$ type, we can realise the measurement through the block $A0$. Because the measurements are in the Y basis, states of logical qubits in $A2$ are preserved, i.e. we do not need to re-prepare the distilled $|y+\rangle$ state. Finally, in the same way, we can measure

ancilla logical qubits in $A1$ in the Y basis. Though the above approach may increase the time cost compared with the transversal S gate, the eventual time cost is still independent of the number of operators to be measured.

Appendix I: Comparison to the protocol in Ref. [16]

In Ref. [16], a protocol for measuring one logical Pauli operator with an ancilla system (called sticker in this paper) is proposed. In the protocol, the ancilla system can measure an arbitrary logical Pauli operator. In our protocol, we can use one measurement sticker to measure an arbitrary number of X or Z logical Pauli operators simultaneously. To measure general logical Pauli operators, we need to use ancilla logical qubits in addition to stickers; see Sec. H. Besides measurement stickers, branch stickers are introduced in our protocol to transfer logical Pauli operators rather than measure them.

For a detailed comparison, we review the protocol in Ref. [16] in the framework of glue codes. To measure a Z logical operator, denoted by \bar{Z} , it is assumed that there are no other Z logical operators on the support $\mathcal{Q}(\bar{Z})$. Under the assumption, taking the naked glue code is sufficient for measuring \bar{Z} , which is exactly the protocol illustrated in Fig. 2 in Ref. [16] (but for a Z operator). To measure the product of two Z logical operators $\bar{Z}_1\bar{Z}_2$, it is assumed that $\mathcal{Q}(\bar{Z}_1)$ and $\mathcal{Q}(\bar{Z}_2)$ does not overlap, and there is no other Z logical operators on the support $\mathcal{Q}(\bar{Z}_1) \cup \mathcal{Q}(\bar{Z}_2)$. In this case, the naked glue code is insufficient because both v_1 and v_2 [$Z(v_1) = \bar{Z}_1$ and $Z(v_2) = \bar{Z}_2$] are in $(\ker H_N)S_N$. We need to remove v_1 and v_2 and leave $v_1 + v_2$ in the space. This can be achieved by taking the dressing matrix $D = \begin{pmatrix} 1 & 1 & 0 & 0 & \cdots \end{pmatrix}$, where the first entry is on the support $\mathcal{Q}(\bar{Z}_1)$ and the second entry is on the support $\mathcal{Q}(\bar{Z}_2)$. By taking such a dressed glue code, we obtain the protocol illustrated in Fig. 3 in Ref. [16] (but for a Z operator). In these examples, the protocol in Ref. [16] corresponds to naked glue codes and instances of dressed glue codes under certain assumptions. In our protocol, the assumption of support is removed. By using a finely devised LDPC glue code, our protocol can measure an arbitrary set of logical operators simultaneously.

The protocol in Ref. [16] is based on three lemmas and one theorem. In the framework of glue codes, these results focus on measurement stickers with naked glue codes under the assumption of supports. The measurement sticker with a naked glue code H_N measures all logical operators on \mathcal{B}_N , which may include logical operators that need not be measured. Our protocol is based on two theorems. Theorem 3 applies to general measurement stickers with finely devised glue codes and branch stickers with coarsely devised glue codes without any assumption of supports. Theorem 4 states the existence of coarsely and finely devised glue codes satisfying the LDPC condition. Upper bounds for costs induced by glue codes are also given in Theorem 4. Using finely devised glue codes or branch stickers, we can realise measurements on an arbitrary set of selected logical operators without measuring other logical operators.

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- [1] J. O’Gorman and E. T. Campbell, Quantum computation with realistic magic-state factories, *Physical Review A* **95**, 032338 (2017).
 - [2] R. Babbush, C. Gidney, D. W. Berry, N. Wiebe, J. McClean, A. Paler, A. Fowler, and H. Neven, Encoding electronic spectra in quantum circuits with linear t complexity, *Physical Review X* **8**, 041015 (2018).
 - [3] A. G. Fowler, M. Mariantoni, J. M. Martinis, and A. N. Cleland, Surface codes: Towards practical large-scale quantum computation, *Phys. Rev. A* **86**, 032324 (2012).
 - [4] D. Gottesman, Fault-tolerant quantum computation with constant overhead (2014), [arXiv:1310.2984 \[quant-ph\]](https://arxiv.org/abs/1310.2984).
 - [5] N. P. Breuckmann and J. N. Eberhardt, Quantum low-density parity-check codes, *PRX Quantum* **2**, 040101 (2021).
 - [6] D. Bluvstein, S. J. Evered, A. A. Geim, S. H. Li, H. Zhou, T. Manovitz, S. Ebadi, M. Cain, M. Kalinowski, D. Hangleiter, J. P. Bonilla Ataides, N. Maskara, I. Cong, X. Gao, P. Sales Rodriguez, T. Karolyshyn, G. Semeghini, M. J. Gullans, M. Greiner, V. Vuletić, and M. D. Lukin, Logical quantum processor based on reconfigurable atom arrays, *Nature* **626**, 58 (2023).
 - [7] S. J. Evered, D. Bluvstein, M. Kalinowski, S. Ebadi, T. Manovitz, H. Zhou, S. H. Li, A. A. Geim, T. T. Wang, N. Maskara, H. Levine, G. Semeghini, M. Greiner, V. Vuletić, and M. D. Lukin, High-fidelity parallel entangling gates on a neutral-atom quantum computer, *Nature* **622**, 268 (2023).
 - [8] M. DeCross, R. Haghshenas, M. Liu, E. Rinaldi, J. Gray, Y. Alexeev, C. H. Baldwin, J. P. Bartolotta, M. Bohn, E. Chertkov, J. Cline, J. Colina, D. DelVento, J. M. Dreiling, C. Foltz, J. P. Gaebler, T. M. Gatterman, C. N. Gilbreth, J. Giles, D. Gresh, A. Hall, A. Hankin, A. Hansen, N. Hewitt, I. Hoffman, C. Holliman, R. B. Hutson, T. Jacobs, J. Johansen, P. J. Lee, E. Lehman, D. Lucchetti, D. Lykov, I. S. Madjarov, B. Mathewson, K. Mayer, M. Mills, P. Niroula, J. M. Pino, C. Roman, M. Schecter, P. E. Siegfried, B. G. Tiemann, C. Volin, J. Walker, R. Shaydulin, M. Pistoia, S. A. Moses, D. Hayes, B. Neyenhuis, R. P. Stutz, and M. Foss-Feig, The computational power of random quantum circuits in arbitrary geometries [10.48550/ARXIV.2406.02501](https://arxiv.org/abs/2406.02501) (2024), [arXiv:2406.02501 \[quant-ph\]](https://arxiv.org/abs/2406.02501).

- [9] A. Grospellier, L. Grouès, A. Krishna, and A. Leverrier, Combining hard and soft decoders for hypergraph product codes, *Quantum* **5**, 432 (2021).
- [10] Q. Xu, J. P. Bonilla Ataides, C. A. Pattison, N. Raveendran, D. Bluvstein, J. Wurtz, B. Vasić, M. D. Lukin, L. Jiang, and H. Zhou, Constant-overhead fault-tolerant quantum computation with reconfigurable atom arrays, *Nat. Phys.* <https://doi.org/10.1038/s41567-024-02479-z> (2024).
- [11] S. Bravyi, A. W. Cross, J. M. Gambetta, D. Maslov, P. Rall, and T. J. Yoder, High-threshold and low-overhead fault-tolerant quantum memory, *Nature* **627**, 778 (2024).
- [12] M. A. Nielsen, Quantum computation by measurement and quantum memory, *Physics Letters A* **308**, 96 (2003).
- [13] D. Horsman, A. G. Fowler, S. Devitt, and R. V. Meter, Surface code quantum computing by lattice surgery, *New J. Phys.* **14**, 123011 (2012).
- [14] C. Vuillot, L. Lao, B. Criger, C. García Almudéver, K. Bertels, and B. M. Terhal, Code deformation and lattice surgery are gauge fixing, *New J. Phys.* **21**, 033028 (2019).
- [15] D. Litinski, A game of surface codes: Large-scale quantum computing with lattice surgery, *Quantum* **3**, 128 (2019).
- [16] L. Z. Cohen, I. H. Kim, S. D. Bartlett, and B. J. Brown, Low-overhead fault-tolerant quantum computing using long-range connectivity, *Sci. Adv.* **8**, 10.1126/sciadv.abn1717 (2022).
- [17] L. M. L. L. D. Landau, *Quantum Mechanics: Non-Relativistic Theory* (Butterworth-Heinemann, 1981).
- [18] P. Panteleev and G. Kalachev, Degenerate quantum ldpc codes with good finite length performance, *Quantum* **5**, 585 (2021).
- [19] A. A. Kovalev and L. P. Pryadko, Improved quantum hypergraph-product ldpc codes, in *IEEE Int. Symp. Inf. Theory - Proc.* (IEEE, 2012).
- [20] J.-P. Tillich and G. Zemor, Quantum ldpc codes with positive rate and minimum distance proportional to the square root of the blocklength, *IEEE Trans. Inf. Theory* **60**, 1193 (2014).
- [21] D. Poulin, Stabilizer formalism for operator quantum error correction, *Physical review letters* **95**, 230504 (2005).